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'IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Anne L. Testoni

Attorney Docket No.: KLA1P100/P1087

Application No.: 10/811,319

Examiner: Unassigned

Filed: March 25, 2004

Group: 2882

Title: AUTOMATIC CLASSIFICATION OF DEFECTS USING PATTERN RECOGNITION APPLIED TO X-RAY SPECTRA

**INFORMATION DISCLOSURE STATEMENT
37 CFR §§1.56 AND 1.97(b)**

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

The references listed in the attached PTO Form 1449 may be material to examination of the above-identified patent application. Applicants submit the list of these references in compliance with their duty of disclosure pursuant to 37 CFR §§1.56 and 1.97. The Examiner is requested to make these references of official record in this application.

This Information Disclosure Statement is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This Information Disclosure Statement is: (i) filed within three (3) months of the filing date of the above-referenced application, (ii) believed to be filed before the mailing date of a first Office Action on the merits, or (iii) believed to be filed before the mailing of a first Office Action after the filing of a Request for Continued Examination under §1.114. Accordingly, it is believed that no fees are due in connection with the filing of this Information Disclosure Statement. However, if it is determined that any fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 500388 (Order No. KLA1P100).

Respectfully submitted,

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Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)			Atty Docket No. KLA1P100/P1087	Application No.: 10/811,319
			Applicant: Anne L. Testoni	
			Filing Date March 25, 2004	Group 2882

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A	5,911,139	06/08/99	Jain et al.	707	3	03/28/97
	B	5,893,095	04/06/99	Jain et al.	707	6	03/28/97
	C	6,233,719	05/15/01	Hardikar et al.	716	1	10/27/97
	D	5,877,498	03/02/99	Sugimoto et al.	250	310	07/15/97
	E	6,104,835	08/15/00	Han	382	225	11/14/99
	F	6,787,773	09/07/04	Lee	250	311	10/23/00
	G						
	H						
	I						

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	J	WO/01/40145A2	07.06.01	WIPO	C06T	7/00	X	
	K							
	L							
	M							
	N							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	O	
	P	
	Q	
Examiner		Date Considered

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.